L Number	Hits	Search Text	DB	Time stamp
2	23	gaku with kamitani	USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/05/12 08:15
3	85	preparing and measuring and obtaining and correcting and impedance	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/05/12
4	1	(gaku with kamitani) and (preparing and measuring and obtaining and correcting and impedance)	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/05/12 08:16
6	2319	preparing and measuring and obtaining and correcting	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/05/12 08:16
7	3	(gaku with kamitani) and (preparing and measuring and obtaining and correcting)	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/05/12 08:17
8	1246	preparing and measuring and obtaining and correcting and (resistance resistive resistor impedance)	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/05/12 08:21
9	3	(gaku with kamitani) and (preparing and measuring and obtaining and correcting and (resistance resistive resistor impedance))	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/05/12 08:39
11	1	(measurement with error) and (chip (electronic with (device component))) and (correction with data with (impedance resistance resistor)) and ((measuring with device) meter) and ((expression equation relation relationship) with actual with standard) and ((correcting correction correct) with (impedance	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/12 08:47
13	1	resistance resistor)) (measurement with error) and (chip (electronic with (device component))) and ((correction correcting) with data with (impedance resistance resistor)) and ((measuring with device) meter) and ((expression equation relation relationship) with actual with standard) and ((correcting correction correct) with	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/12 08:49
12	2	<pre>(impedance resistance resistor)) ((correction correcting) with data with (impedance resistance resistor)) and</pre>	USPAT; US-PGPUB;	2004/05/12 _08:47
14	23	((measuring with device) meter) and ((expression equation relation relationship) with actual with standard) and ((correcting correction correct) with (impedance resistance resistor))	EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/12
		relationship)) and ((correcting correction correct) with (impedance resistance resistor))		·.

15	23	((measurement with error) and (chip	USPAT;	2004/05/12
	1	(electronic with (device component))) and	US-PGPUB;	08:55
		((correction correcting) with data with	EPO; JPO;	
		(impedance resistance resistor)) and	DERWENT;	
	1	((measuring with device) meter) and	IBM_TDB	
		((expression equation relation	_	
		relationship)) and ((correcting		
		correction correct) with (impedance		
		resistance resistor))) and ((impedance		
-		resistance resistor) with (error		
	1	correcting correction))		

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